

**Search Notes**

Application/Control No.

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Examiner

Marlon A. Arce-Diaz

Applicant(s)/Patent under  
Reexamination

YANG ET AL.

Art Unit

3611

**SEARCHED**

Class	Subclass	Date	Examiner
180	8.2,8.1, 8.3,8.5, 901	1/2/2007	MAA

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR